



Communication

# Advanced Mapping of Optically-Blind and Optically-Active Nitrogen Chemical Impurities in Natural Diamonds

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Abstract: Natural diamonds with a rich variety of optically blind and optically active nitrogen impurity centers were explored at a nano/microscale on the surface and in bulk by a number of advanced chemical and structural analytical tools in order to achieve a comprehensive characterization by establishing enlightening links between their analysis results. First, novel compositional relationships were established between high-energy X-ray photoelectron spectroscopy (XPS) and low-energy Fourier-transform infrared vibrational spectroscopy (FT-IR) signals of nitrogen impurity defects acquired in the microscopy mode at the same positions of the diamond surface, indicating the verification XPS modality for qualitative and quantitative FT-IR analysis of high concentrations of nitrogen and other chemical impurity defects in diamond. Second, depth-dependent spatial distributions of diverse photoluminescence (PL)-active nitrogen defects were acquired in the confocal scanning mode in an octahedral diamond and then for the first time corrected to the related Raman signals of the carbon lattice to rule out artefacts of the confocal parameter and to reveal different micron-scale ontogenetic layers in the impurity distributions on its surface. Third, intriguing connections between local structural micro-scale defects (dislocation slip bands of plastic deformation zones) visualized by optical microscopy and Raman microspectroscopy, and related distributions of stress-sensitive PL-active nitrogen impurity defects in the proximity of these planes inside bulk diamonds were revealed. These findings demonstrate the broad instrumental opportunities for comprehensive in situ studies of the chemical, structural, and mechanical micro-features in diamonds, from the surface into bulk.

**Keywords:** natural diamonds; nitrogen impurity; spatial distributions; ontogenetic layers; dislocations; stresses; infrared microspectroscopy; X-ray photoelectron spectroscopy; confocal Raman; photoluminescence microspectroscopy

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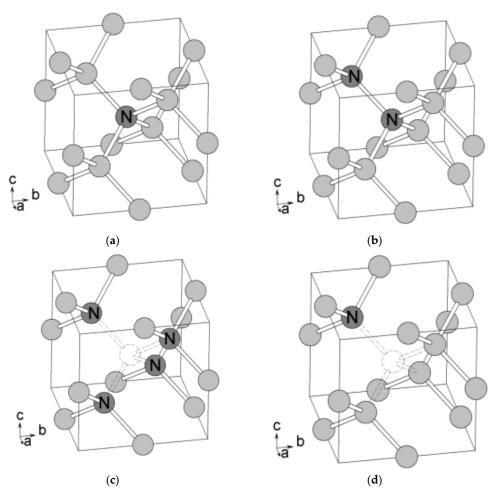
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#### 1. Introduction

Despite their unprecedented transparency, high-index brightness, and attractive colors harnessed in optics, optoelectronics, and jewelry, natural diamonds carry out tremendous (up to 0.1-1 at. %) concentrations of atomistic intrinsic and impurity defects (mostly, nitrogen ones [1-5]), considerably masked by their ultra-rigid crystalline lattice (Supplementary materials). The variety of nitrogen impurity defects (Figure 1), partially combined with intrinsic (carbon interstitials I and vacancies V) ones, differs in its composition, symmetry and configuration, thermodynamic stability, optical (UV-vis and IR absorption) and electronic (electron orbital or spin momentum) properties [1]. These intrinsic structural characteristics dictate many of the crucial properties of the resulting material and, thus, require that they control different analytical methods—UV-vis and IR transmission spectroscopy, PL spectroscopy, electron paramagnetic resonance (EPR) spectroscopy, and even more sophisticated methods to characterize their corresponding relevant properties in the bulk of the hardest

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material [2,3,5]. Meanwhile, local microscale structural defects—radioactive inclusions, growth layers, plastically-deformed zones, voidities, and platelets [2,3,6,7]—could also strongly modulate distributions of impurities, making their overall macroscopic analysis unreliable.



**Figure 1.** Main types of nitrogen impurity defects in diamonds: (a) N (C-center), (b) 2N (A-center), (c) 4NV (B-center), (d) NV-center [4].

For most nitrogen impurity defects, depending on the symmetry of their configuration and related electronic structure, typically either optical (UV-vis, IR-transmission, PL) or electronic (EPR) characterization methods are employed [1–18]. As a result, for the comprehensive characterization of the abundance of nitrogen impurity defects in bulk natural diamonds, a number of complementary analytical methods are required, which are still not always available for the microscopic characterization of impurity distributions between different growth sectors and extended microscopic defects in real natural diamonds, even in common daily gemological practice.

Specifically, FT-IR analysis is commonly used for determining nitrogen concentration in diamonds, enabling measurements of average quantities up to  $3\times10^3$  ppm [8], with a spatial resolution with a depth of ~100 µm, according to typical absorption coefficients of nitrogen in one-phonon range ~10–10² cm $^{-1}$  [1,3,4]. Hence, both the local and high-concentration acquisition of nitrogen abundance becomes impossible by FT-IR spectroscopy (even, in its microscopy mode) in micro-scale internal features in diamonds (sharp interfaces of growth and plastic deformation zones [9–11], inclusions [12]). Alternatively, the X-ray photoelectron micro-spectroscopy method is known to provide surfaces with a high spatial resolution (~10–10² µm laterally, ~10–10² nm in depth) and a broad dynamic range of measurable impurity concentrations, starting from ~0.1 at. % (>10³ ppm) but

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has been never used for the evaluation of nitrogen abundance in diamonds [13–15]. In contrast, in studies of minute internal diamond structures, either ontogenetic evolutionary growth zones (core, mantle, periphery) [8,9] or plastic deformation zones decorated by impurity centers [11,16,17], FT-IR [11], or EPR [4,18] methods appear uninformative due to macroscopic acquisition, while more envisioning tools such as cathodoluminescence (CL) with is micrometer-deep probing layer still require technically challenging and sometimes impossible diamond slicing into thin plates for CL mapping [8,9]. Overall, extensive diverse microscopic studies of natural diamonds enriched by various nitrogen impurity defects and different structural imperfections (dislocations, platelets, voidities etc.), are still demanded by properly chosen and relevant analytical methods to establish the unambiguously important connections between their chemical, structural, optical, and mechanical properties in situ.

In this study, our primary mission was in demonstrating novel applications of different advanced high-resolution microspectroscopic analytical methods (XPS, 3D-scanning PL/Raman micro-spectroscopy) for in situ studies of micro-scale structural or chemical features in natural diamonds on surfaces and in bulk, related to nitrogen impurity defects, and establishing useful links between the measured various chemical, mechanical, and optical characteristics.

#### 2. Materials and Methods

In these experiments, we used natural diamonds of different shapes (dodecahedral habit and plates made from octahedron, sometimes rather irregular, almost spherical shapes—see below) and compositional types (IaAB, IaB) from M. V. Lomonosov (Arkhangelsk province) and Ebelyakh (Anabar region) deposits of Russia [18–21].

In order to derive the concentrations of nitrogen impurity defects in the 100-micron thick surface layer of diamonds, the samples were characterized in ambient air by room-temperature (RT) Fourier-transform infrared (FT-IR) transmission microspectroscopy (spectral range—400–4000 cm $^{-1}$ , resolution—1 cm $^{-1}$ ), using a spectrometer Optics IFS-125HR (Bruker, Billerica, MA, USA) with a microscope Hyperion 2000 (Bruker, Billerica, MA, USA).

The chemical bonding of nitrogen impurity and intrinsic carbon atoms was studied on the diamond surfaces by means of an X-ray photoelectron spectrometer K-Alpha (Thermo Fisher Scientific, Waltham, MA, USA). The photoelectron spectra were acquired for 225 s each using an Al-K $\alpha$  line as an excitation source at the energy accuracy of 0.1 eV and composition accuracy of 0.1 at. %, from the spot of 200- $\mu$ m in diameter, using 40-eV pass energy for high-resolution spectra. The spectrometer was calibrated to the binding energy of an Au  $4f_{7/2}$  line at 84.00 eV.

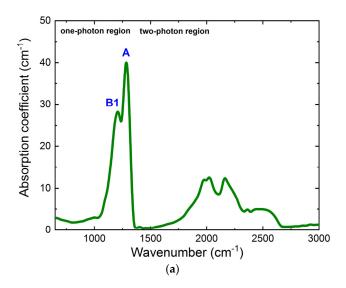
RT PL spectra of the samples were acquired by 3D-scanning confocal Raman/PL microspectroscopy and using Alpha 300 AR (WiTec, London, UK) and Confotec 350 (SOL instruments, Minsk, Belorussia) microscopes-spectrometers at 405-, 488- and 532-nm laser excitation wavelengths (spectral resolution—0.5 nm), using 0.3-NA Nikon objectives and excitation laser power not exceeding 50 mW.

#### 3. Results and Discussion

3.1. Surface Concentration Measurements for Optically Blind and Optically Active Nirogen Impurity Defects via XPS Probing of Their Chemical States

Some nitrogen impurity defects are optically blind in PL spectra (2N/A, 4N2V/B1, B2 etc. [1,3,5–8,18]) and can be identified only by FT-IR spectroscopy (Figure 2) if average concentrations are not too high. In Table 1, there are the corresponding FT-IR microspectroscopy results of the compositional analysis for surface spots of a few natural diamonds, showing the abundance of the different nitrogen impurity defects up to 10<sup>3</sup> ppm, according to the calibration procedures reported in refs. [21–23]. It is noteworthy that high impurity (e.g., nitrogen) concentrations (>10<sup>3</sup> ppm) in diamonds in many cases are challenging for FT-IR measurements due to total IR-light absorbance (noise-level transmittance) even in moderately thick diamonds.

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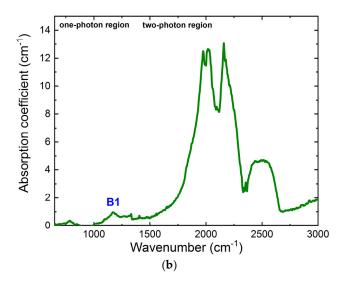


Figure 2. FT-IR spectra of natural diamonds: (a) IaAB (1784-8-1); (b) IaB (EV-8-5).

**Table 1.** Content of different nitrogen impurity defects in IaAB and IaB diamonds.

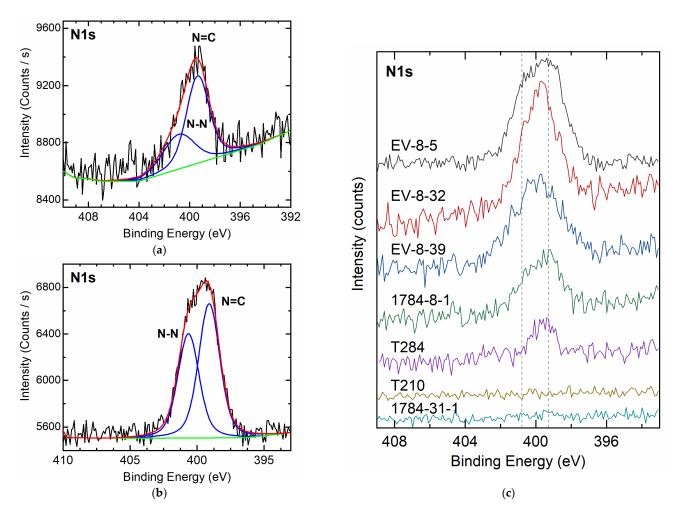
Sample	Color	Shape	IR Data					
			N <sub>total</sub> , ppm	A, ppm	B1, ppm	Platelets, cm <sup>−1</sup>	C, ppm	
1784-8-1 (IaAB)	pink	dodecahedral habit	$1085\pm109$	910 ± 91	$175\pm18$	-	0	
1784-31-1 (IaAB)	brown	octahedral habit	$187 \pm 19$	100 ± 10	87 ± 9	2	0	
EV-8-5 (IaB)	colorless	dodecahedral habit	33 ± 3	-	33 ± 3	-	0	
EV-8-32 (IaAB)	colorless	dodecahedral habit	$455\pm45$	$264\pm26$	191 ± 19	21	0	
EV-8-39 (IaAB)	colorless	dodecahedral habit	890 ± 89	330 ± 33	$560 \pm 56$	-	0	
T-210 (IaB)	colorless	plate	62 ± 6	-	62 ± 6	-	0	
T-284 (IaAB)	colorless	plate	$280\pm28$	$165\pm17$	$115\pm12$	8	0	

In comparison, we have suggested, for the first time, employing an XPS method for the evaluation of nitrogen concentration in the surface layer of these diamonds (Table 2), while previous XPS studies were focused on other impurities [13,14] or structural states of carbon in diamonds [15]. Below, we compare the FT-IR results with the relative content in atomic % of C–N and N–N bonds in these defects, according to the intensities of their XPS peaks (Figure 3). Previously, such a qualitative comparison was performed in refs. [24–30], though without deep analysis. Here, we assign N–N bonds to only the 2N(A)-centers [27,29], while C–N bonds are present in all types of nitrogen impurity defects.

Table 2. Nitrogen content in C-N and N-N bonding states in the diamonds measured by XPS.

Sample	1784-8-1 (IaAB)	1784-31-1 (IaAB)	EV-8-5 (IaB)	EV-8-32 (IaAB)	EV-8-39 (IaAB)	T-210 (IaB)	T-284 (IaAB)
C-N, at. %	$0.49\pm0.02$	0	$0.66\pm0.03$	$0.52\pm0.03$	$0.56\pm0.03$	0	$0.38\pm0.02$
N–N, at. %	$0.19 \pm 0.01$	0	$0.44 \pm 0.02$	$0.16 \pm 0.01$	$0.38 \pm 0.02$	0	$0.14 \pm 0.01$

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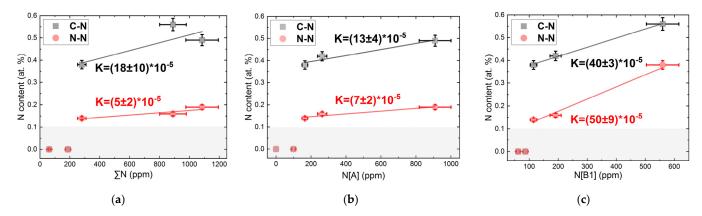


**Figure 3.** Typical XPS spectra of natural diamonds containing N–N and/or C–N bonding: (a) IaAB (1784-8-1); (b) IaB (EV-8-5); (c) comparison of all samples. Insets: white-light images of the diamonds under study. The low-intensity and noisy XPS signals result from the highly irregular shapes of the diamonds at the sub-millimeter scale, despite the rather long, 225-s acquisition (exposition) time.

Furthermore, we explored the correlation between the XPS-based contents of nitrogen atoms in N–N and C–N bonds in at. % and FT-IR-based concentrations of the different nitrogen impurity defects in ppm (Figure 4). Accounting for the XPS detection limit of 0.1 at. %, these plots reasonably indicate the linear calibration relationship between XPS N–N intensity and  $\Sigma_N$  (Figure 4a), similar to XPS C–N intensity and  $\Sigma_N$ . The same is true for the other plots—XPS N–N intensity versus [A] (Figure 4b), and XPS C–N intensity versus [B1] (Figure 4c).

Overall, these studies indicate that our XPS probing of the chemical states of nitrogen impurity defects, accompanied by statistical analysis, could provide the envisioning insight into their quantitative abundance on the very surfaces of natural diamonds compared with FT-IR probing depths  $\sim\!10^2\!-\!10^3$  µm (typical measurable IR absorption coefficients  $\sim\!10\!-\!10^2$  cm $^{-1}$  [1,6,8,12,18,22]). As a result, the XPS-measured concentrations generally differ from the FT-IR measured ones, indicating their only order-of-magnitude correspondence (Figure 4). Hence, in addition to the rather standard FT-IR (micro)spectroscopy of bulk diamonds, a less sensitive XPS method could measure high concentrations (>10^3 ppm) of nitrogen and other chemical impurities, thus making possible not only qualitative but also broad-range quantitative analysis for their combination.

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**Figure 4.** Correlation plots for IaAB and IaB diamonds: (a) XPS-acquired N–N and C–N intensities versus  $\Sigma_N$ ; (b) XPS-acquired N–N and C–N intensities versus [A]; (c) XPS-acquired N–N and C–N intensities versus [B1]. The bottom grey highlighted band denotes the device detection limit of 0.1 at. %.

### 3.2. Raman Correction of Depth-Dependent PL-Active Nitrogen Impurity Abundance in Bulk Diamond

In this section, we explore the octahedral natural IaAB-diamond to identify the ontogenetic evolutionary transition (new growth or modification) layer on its surface via depth-dependent 3D-scanning confocal PL/Raman acquisition, utilizing the Raman intensity dependence on the depth to correct the PL yield of N3 and H3/H4 centers for the confocal probe factor [1,5,7,31–34]. Typically, for this purpose, the diamond under study is sliced into thin plates for their cross-sectional surface CL mapping of nitrogen impurity centers [9,10].

In these experiments, we acquired the 3D PL and Raman spectra of the octahedral natural IaAB-diamond, excited at the 405-nm wavelength (for comparison—also at 532 nm), as a function of depth  $z \leq 200~\mu m$  inside it (Figure 5). These spectra exhibit in Figure 5a a 428-nm Raman line and PL bands of N3 (ZPL at 415 nm [1,3,5,7]) and H3/H4-centers (ZPLs at 496 and 503 nm [1,3,5,7]). Both the Raman and PL intensities demonstrated the diminished magnitudes close to the sample surface: for the Raman signal—in the surface layer of  $\approx$ 25  $\mu m$  (Figure 5b,  $\approx$ 50  $\mu m$  at the 532-nm wavelength); for the N3-band—in the 100- $\mu m$  thick layer; and for the H3/H4-bands—in the 75- $\mu m$  thick layer (Figure 5c). Meanwhile, in bulk, the Raman signal from the ultra-stable diamond lattice comes to true saturation, exhibiting the only near-surface diminishing effect.

Importantly, the Raman signals demonstrate the much thinner layer of diminished intensity, which is divergence- and wavelength-dependent, e.g., thicker at the 532-nm wavelength by a factor of 532 nm/405 nm  $\approx$  1.35. We considered this near-surface reduction of the Raman intensity as a confocal effect, resulting from the incomplete/partial laser focus arrangement inside the sample. The Raleigh length  $L_R$  for our acquisition conditions ( $\lambda=405$  nm, NA = 0.25) was equal to

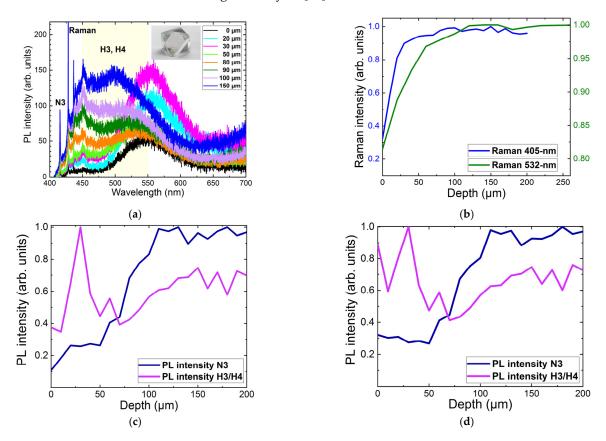
$$2L_{R} \propto 2 \frac{\lambda \left(n^{2} - NA^{2}\right)}{nNA^{2}} \approx 30 \ \mu\text{m}, \tag{1}$$

in good agreement with the observed thickness of the layer of reduced Raman signal excited at 405-nm wavelength. Hence, we can consider the surface decrease of the Raman intensity as a purely instrumental effect and perform a normalization of the depth-dependent PL intensities to the Raman one.

In Figure 5d, one can see the normalized depth dependencies of the PL intensity of the N3 and H3/H4 centers. Obviously, despite the right shape of the gem, its surface layer of a thickness of  $\sim 100~\mu m$  is strongly depleted by N3 centers but enriched by H3/H4 ones. This could correspond to a transition layer, either modified by some occasional chemical and

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physical (radioactivity etc.) perturbation factors or its new regression ontogenetic growth zone of a different composition regarding the nitrogen impurity centers [5,6,18,33]. Such layered differences in N3 and H3/H4 abundance in natural diamonds are known to occur in different ontogenetic layers [34].



**Figure 5.** (a) PL/Raman spectra of IaAB diamond at different depths (405-nm excitation). Inset: the image of the octahedral diamond; (b) Depth dependence of normalized Raman signal excited at 405 and 532 nm; (c) Depth dependence of normalized PL yield of N3 (415 nm) and H3/H4 centers, taken at 550 nm, excited at 405 nm; (d) Depth dependence of normalized PL yield of N3 (415 nm) centers and H3/H4 (550 nm) centers, excited at 405 nm and corrected for the depth dependence of the Raman signal.

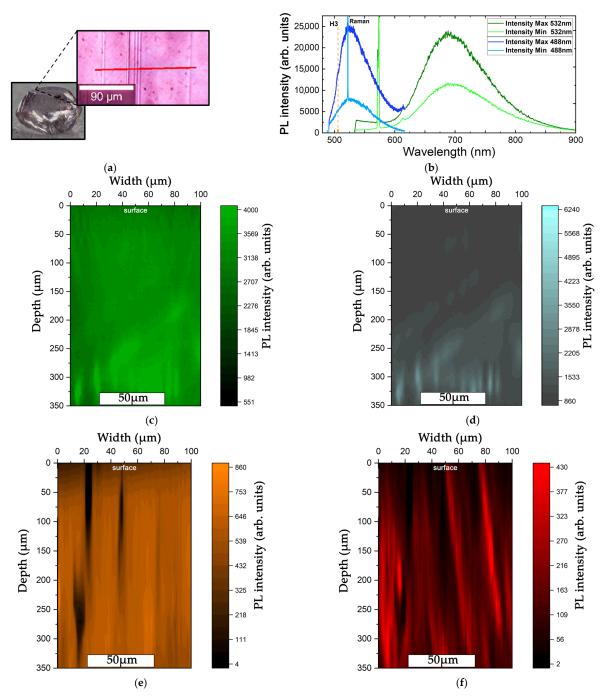
Overall, our microscale 3D-scanning confocal Raman/PL microspectroscopic in-depth mapping of a sub-mm thick subsurface layer in an octahedral natural IaAB-diamond was performed, accounting for the first time the confocal correction via normalization of the spatially inhomogeneous PL signal to the Raman one. This procedure enabled the identification of the modified internal chemical structure of the diamond and established the inhomogeneous, anti-correlating abundance of the characteristic N3 and H3/H4 nitrogen impurity centers across it, without the diamond slicing into thin plates [9,10], potentially reflecting different ontogenetic layers during the diamond formation.

## 3.3. Correlation between Local Plastic Deformations and Distribution of PL-Active Nitrogen Impurity Defects

In this section, we explore microscopic plastic deformation zones (lamellae) related to dislocation slip bands in brown [11,16,17] and pink [11] diamonds and decorated by vacancies (vacancy clusters) [16,17] and N3, H3/H4 nitrogen impurity centers [11]. In our case, the distinct micro-scale bands were observed inside a rare bulk pink-brown diamond by optical microscopy (Figure 6a) but do not directly coincide with the pink coloration patterns provided by H3(2NV), H4(4N2V) centers (ZPLs at  $\approx$ 500 nm, peak at  $\approx$ 550 nm) [6,19–22,35], NV<sup>0</sup>-centers (ZPL at 575 nm, peak at  $\approx$ 650 nm) [1,7,36] and

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dislocation-related centers (peak at  $\approx$ 700 nm) [28,32,36]. Below, we used the combination of optical transmission microscopy and 3D-scanning confocal Raman/PL microspectroscopy to identify microscopic plastic deformation zones inside the diamond and relate them to stress-sensitive distributions of PL-active nitrogen impurity defects [28,36].



**Figure 6.** (a) Optical image of the diamond and (inset) its magnified view in the near-surface region with microscale plastic deformation zones; (b) Raman and PL spectra of the plastic deformation zones (Intensity Max) and reference spot outside zones (Intensity Min), excited at 488- and 532-nm wavelengths; (c) Raman map of the diamond at 522-nm wavelength (excitation wavelength—488 nm); (d) PL map of the diamond at 550-nm wavelength, representing the spatial abundance of H3/H4 centers (excitation wavelength—488 nm); (e) Raman map of the diamond at 573-nm wavelength (excitation wavelength, representing dislocation-related centers (excitation wavelength—532 nm).

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In Figure 6, the optical image (a) and corresponding Raman/PL maps (c–f) of the near-surface region in the bulk diamond are shown. Interestingly, a few-micron periods of the plastic deformation (PD) zones in the optical image partially replicate the period of the bright Raman (Figure 6c,e) and PL (Figure 6d,f) intensity features across the sample.

As we can see in the detailed spectra (Figure 6b), the overall spectral fingerprint in the PD area fully repeats the spectral fingerprint of the surrounding diamond, which means that they contain the same nitrogen impurity centers. In the spectra, we can see the Raman lines at 522 nm (488 nm excitation) and 573 nm (532 nm excitation), the green-yellow PL band of H3/H4 centers [1,7,28,34,35], where the H3 center could be considered an A(N–N)-center with a vacancy inside, making an N–V–N structure and red PL band of NV<sup>-</sup>-centers [1,5,18] or dislocation-related centers [1,3,4,7,11,16,17]. Since PD zones cover the entire diamond, periodic bands of complex nitrogen impurity defects are also observed in the PL yield across the whole volume of the gem (Figure 6d,e).

Specifically, in Figure 6c,d, one can see the good correspondence between the Raman and H3/H4 PL peaks in the maps, indicating that the brighter plastically deformed zone induced the enhanced Raman signal and attracted additional highly aggregated H3/H4 centers, increasing in situ their PL yield. Intriguingly, in Figure 6e,f, there is a general correspondence between the Raman and 700-nm-PL peaks at the moderate intensity level, which is surprising except for a few very bright PL spots, which are absent in the Raman map. Apparently, mechanical stresses are relaxed in some of these dislocation-related micro-scale features, while their atomistic internal structure induces the observed strong compositional modulation in the 700-nm PL intensity. Additional multi-spectral analysis in our forthcoming studies could give enlightening insights into the origin and structure of the observed dislocation-related PL centers.

#### 4. Conclusions

In our study, various types of electrons, IR, Raman/PL, and optical microscopy methods were employed in pairs to provide complementary enlightening insights into the chemical or structural properties of microscale features in diamonds. Using nitrogen impurities in diamonds as an example, X-ray photoelectron microspectroscopy was demonstrated to verify FR-IR microspectroscopy findings in a qualitative and quantitative analysis of different chemical impurities present in a broad range of concentrations. Raman scattering analysis was shown to enable spatial confocal corrections of PL yield for different nitrogen centers in the multi-micron thick near-surface diamond layer, which typically represents different ontogenetic formation zones in diamonds. Finally, optical imaging of plastic deformation microzones and their Raman/PL microspectroscopy mapping of stresses and nitrogen impurity concentrations revealed their distinct correlation, enabling our forthcoming detailed studies in specially prepared thin diamond plates. Overall, the overviewed versatile microscopy methods characterize from different viewpoints the interesting and challenging "evergreen" compositional or structural microscale features on the surface and in bulk diamonds, in order to shed light on their origin and internal structure.

**Supplementary Materials:** The following supporting information can be downloaded at: https://www.mdpi.com/article/10.3390/chemosensors11010024/s1, Table S1: Characterization of coloured diamonds.

**Author Contributions:** Conceptualization, S.K. and G.K.; methodology, P.D.; software, E.K.; validation, R.K., E.R. and E.K.; investigation, V.P. and A.M.; resources, R.K. and G.K.; data curation, P.D.; writing—original draft preparation, S.K., E.R. and V.P.; writing—review and editing, S.K., E.R., G.K. and V.S.; visualization, E.K. and E.G.; supervision, G.K.; project administration, S.K.; funding acquisition, S.K. All authors have read and agreed to the published version of the manuscript.

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